TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT Process)

2SC4682

Strobe Flash Applications Medium Power Amplifier Applications

• Excellent hFE linearity: hFE (1) = 800 to 3200 (VCE = 1 V, IC = 0.5 A)

 $h_{E} = 1 \text{ (2)} = 500 \text{ (typ.)} \text{ (VCE} = 1 \text{ V, IC} = 3 \text{ A)}$

• Low saturation voltage: $V_{CE (sat)} = 0.5 \text{ V (max)}$ ($I_{C} = 3 \text{ A}, I_{B} = 30 \text{ mA}$)

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V _{CBO}	30	V	
Collector-emitter voltage		V _{CES}	30	V	
		V (BR) CEO	15		
Emitter-base voltage		V _{EBO}	6	V	
Collector current	DC	I _C	3	Α	
	Pulse	I _{CP}	6		
Base current		Ι _Β	0.8	Α	
Collector power dissipation		PC	900	mW	
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	−55 to 150	°C	

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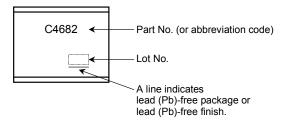
Weight: 0.36 g (typ.)

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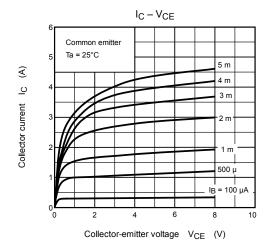
Electrical Characteristics (Ta = 25°C)

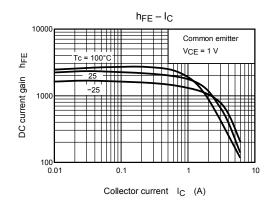
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	V _{CB} = 30 V, I _E = 0	_	_	1	μΑ
Emitter cut-off current	I _{EBO}	V _{EB} = 6 V, I _C = 0	_	_	10	μA
Collector-emitter breakdown voltage	V (BR) CEO	I _C = 10 mA, I _B = 0	15	_	_	V
DC current gain	h _{FE (1)}	V _{CE} = 1 V, I _C = 0.5 A	800	_	3200	
	h _{FE (2)}	V _{CE} = 1 V, I _C = 3 A	300	500	_	
Collector-emitter saturation voltage	V _{CE (sat)}	I _C = 3 A, I _B = 30 mA	_	0.25	0.5	V
Base-emitter voltage	V_{BE}	V _{CE} = 1 V, I _C = 3 A	_	0.85	1.2	V
Transition frequency	f _T	V _{CE} = 1 V, I _C = 0.5 A	_	150	_	MHz
Collector output capacitance	C _{ob}	V _{CB} = 10 V, I _E = 0, f = 1 MHz	_	30	_	pF

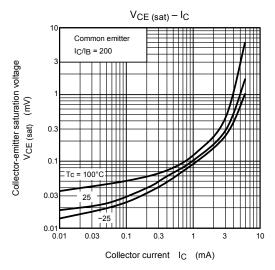
Marking

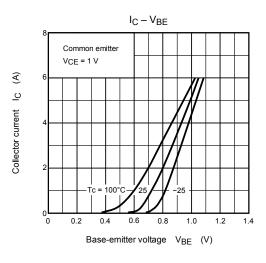


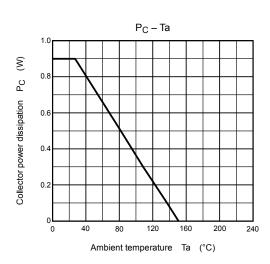
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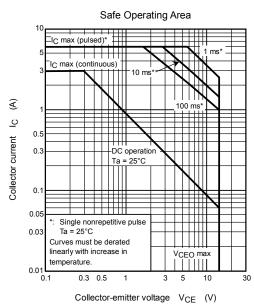












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